


<b>Search Notes</b>  	<b>Application/Control No.</b>  10811165	<b>Applicant(s)/Patent Under Reexamination</b>  SCHULTZ ET AL.
	<b>Examiner</b>  Wendmagegn, Girumsew	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	68	8/29/2007	gw
386	81	8/29/2007	gw
386	111	8/29/2007	gw

SEARCH NOTES		
Search Notes	Date	Examiner
US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB	8/28/2007	gw
Consulted: Thai Tran, James Fletecher	8/28/2007	gw
Inventor(s) search	8/29/2007	gw

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner